

RoH

V

А

mJ

А

mJ

W

°C

lbf ⋅ in

N·m

10

1.1

COMPLIANT

## IXTH24P20-VB Datasheet

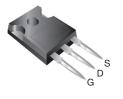
## **Power MOSFET**

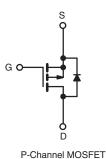
PRODUCT SUMMARY						
V <sub>DS</sub> (V)	- 100					
R <sub>DS(on)</sub> (Ω)	V <sub>GS</sub> = - 10 V	0.20				
Q <sub>g</sub> (Max.) (nC)	61					
Q <sub>gs</sub> (nC)	14					
Q <sub>gd</sub> (nC)	29					
Configuration	Single					

#### **FEATURES**

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- P-Channel
- Isolated Central Mounting Hole
- 175 °C Operating Temperature
- Fast Switching
- · Ease of Paralleling
- Compliant to RoHS Directive 2002/95/EC

**TO-247AC** 





ABSOLUTE MAXIMUM RATINGS (T<sub>C</sub> = 25 °C, unless otherwise noted) PARAMETER SYMBOL UNIT LIMIT Drain-Source Voltage  $V_{DS}$ - 100 Gate-Source Voltage  $V_{GS}$ ± 20  $T_C = 25 \ \overline{^{\circ}C}$ - 21 Continuous Drain Current V<sub>GS</sub> at - 10 V  $I_{\mathsf{D}}$  $T_C = 100 \degree C$ - 15 Pulsed Drain Currenta - 84  $I_{DM}$ W/°C Linear Derating Factor 1.2 E<sub>AS</sub> Single Pulse Avalanche Energy<sup>b</sup> 960 Repetitive Avalanche Current<sup>a</sup>  $I_{AR}$ - 21 Repetitive Avalanche Energy<sup>a</sup>  $E_{AR}$ 18 Maximum Power Dissipation T<sub>C</sub> = 25 °C 180  $\mathsf{P}_\mathsf{D}$ dV/dt - 5.5 V/ns Peak Diode Recovery dV/dtc - 55 to + 175 Operating Junction and Storage Temperature Range T<sub>J</sub>, T<sub>stg</sub> Soldering Recommendations (Peak Temperature) for 10 s 300<sup>d</sup>

6-32 or M3 screw

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b.  $V_{DD} = -25 \text{ V}$ , starting  $T_J = 25 \text{ °C}$ , L = 3.3 mH,  $R_g = 25 \Omega$ ,  $I_{AS} = -21 \text{ A}$  (see fig. 12). c.  $I_{SD} \le -21 \text{ A}$ , dl/dt  $\le 200 \text{ A/}\mu$ s,  $V_{DD} \le V_{DS}$ ,  $T_J \le 175 \text{ °C}$ . d. 1.6 mm from case.

Mounting Torque

\* Pb containing terminations are not RoHS compliant, exemptions may apply



THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	TYP.	MAX.	UNIT		
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	40			
Case-to-Sink, Flat, Greased Surface	R <sub>thCS</sub>	0.24	-	°C/W		
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	0.83			

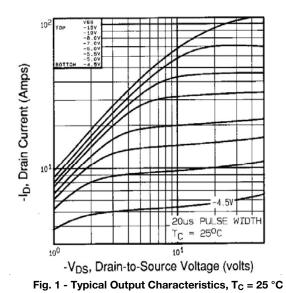
<b>SPECIFICATIONS</b> (T <sub>J</sub> = 25 $^{\circ}$ C,	unless otherv	vise noted)					
PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, \text{ I}_{D} = -250 \mu\text{A}$		- 100	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_J$	Reference to	Reference to 25 °C, I <sub>D</sub> = - 1 mA		- 0.087	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{C}$	$V_{DS} = V_{GS}, I_D = -250 \ \mu A$		-	- 4.0	V
Gate-Source Leakage	I <sub>GSS</sub>	$V_{GS} = \pm 20 \text{ V}$		-	-	± 100	nA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = -100 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$		-	-	- 100	μA
		V <sub>DS</sub> = - 80 V, \	$V_{DS}$ = - 80 V, $V_{GS}$ = 0 V, $T_{J}$ = 150 °C		-	- 500	
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = - 10 V	I <sub>D</sub> = - 13 A <sup>b</sup>	-	0.20	-	Ω
Forward Transconductance	<b>g</b> <sub>fs</sub>	V <sub>DS</sub> = - 50 V, I <sub>D</sub> = - 13 A <sup>b</sup>		6.2	-	-	S
Dynamic							
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = - 25 V,		-	1400	-	pF
Output Capacitance	C <sub>oss</sub>			-	590	-	
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1.0	MHz, see fig. 5	-	140	-	1
Total Gate Charge	Qg	V <sub>GS</sub> = - 10 V I <sub>D</sub> = - 19 A, V <sub>DS</sub> = - 80 V, see fig. 6 and 13 <sup>b</sup>		-	-	61	
Gate-Source Charge	Q <sub>gs</sub>		-	-	14	nC	
Gate-Drain Charge	Q <sub>gd</sub>		see lig. 0 and 15	-	-	29	1
Turn-On Delay Time	t <sub>d(on)</sub>				16	-	ns
Rise Time	t <sub>r</sub>	$V_{DD}=\text{-}~50~\text{V},~\text{I}_{D}=\text{-}~19~\text{A},$ $\text{R}_{g}=9.1~\Omega,~\text{R}_{D}=2.4~\Omega,~\text{see fig.}~10^{\text{b}}$		-	73	-	
Turn-Off Delay Time	t <sub>d(off)</sub>			-	34	-	
Fall Time	t <sub>f</sub>			-	57	-	
Internal Drain Inductance	L <sub>D</sub>	Between lead, 6 mm (0.25") from package and center of die contact		-	5.0	-	- nH
Internal Source Inductance	L <sub>S</sub>			-	13	-	
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	- 21	A
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	-	- 84	
Body Diode Voltage	$V_{SD}$	$T_J = 25 \ ^\circ C, \ I_S = - \ 21 \ A, \ V_{GS} = 0 \ V^b$		-	-	- 5.0	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	- T <sub>J</sub> = 25 °C, I <sub>F</sub> = - 19 A, dl/dt = 100 A/μs <sup>b</sup>		-	130	260	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	0.35	0.70	μC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S$ and $L_D$ )					

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width  $\leq$  300 µs; duty cycle  $\leq$  2 %.





### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

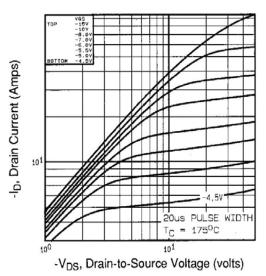


Fig. 2 - Typical Output Characteristics,  $T_C$  = 175 °C

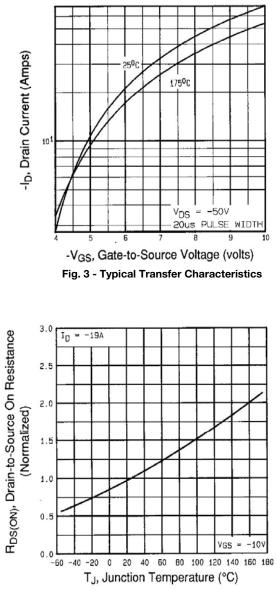


Fig. 4 - Normalized On-Resistance vs. Temperature



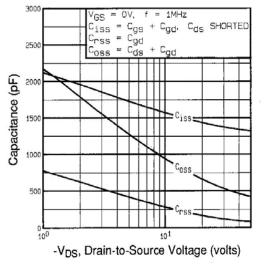
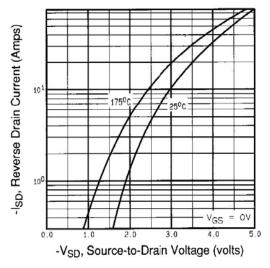


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage





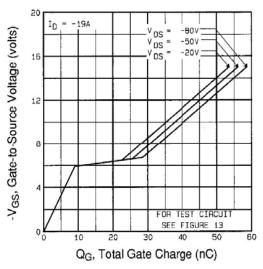
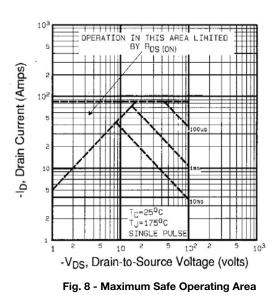


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage





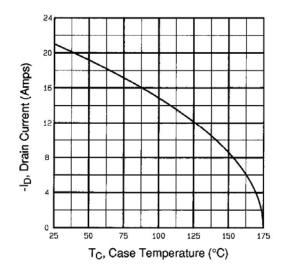


Fig. 9 - Maximum Drain Current vs. Case Temperature

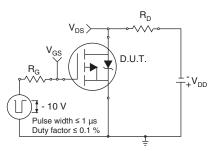


Fig. 10a - Switching Time Test Circuit

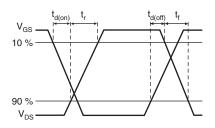


Fig. 10b - Switching Time Waveforms

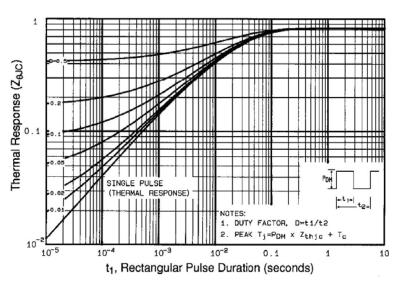


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



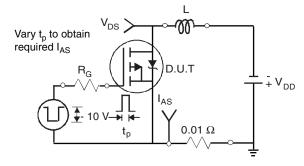


Fig. 12a - Unclamped Inductive Test Circuit

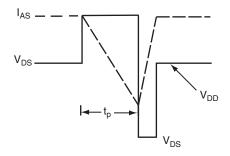


Fig. 12b - Unclamped Inductive Waveforms

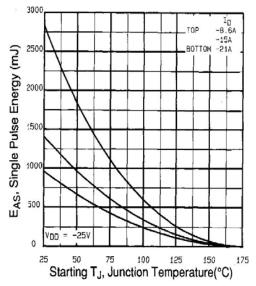


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

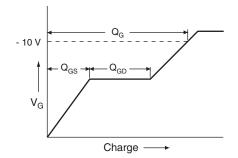


Fig. 13a - Basic Gate Charge Waveform

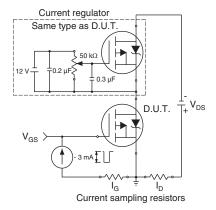
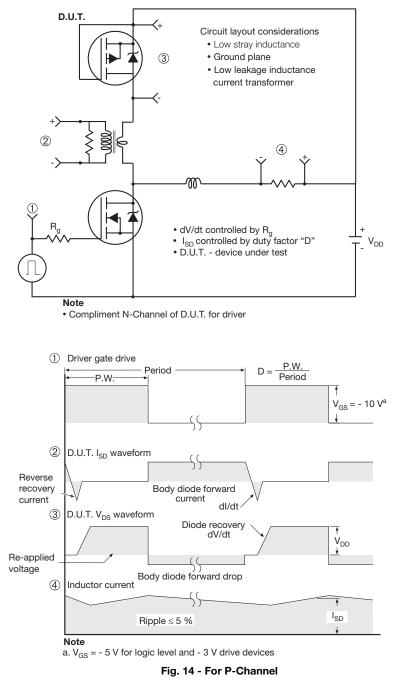


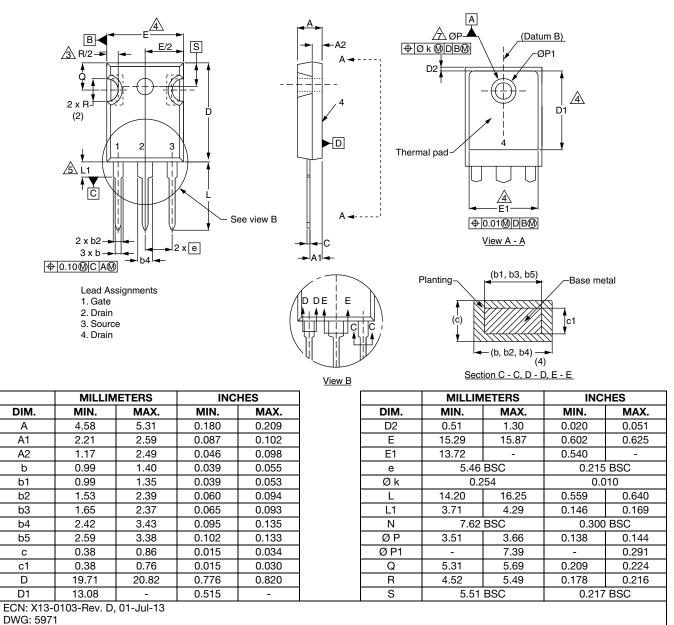
Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit







## **TO-247AC (High Voltage)**

Notes

1. Dimensioning and tolerancing per ASME Y14.5M-1994.

2. Contour of slot optional.

3. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outermost extremes of the plastic body.

Thermal pad contour optional with dimensions D1 and E1.
Lead finish uncontrolled in L1.

6. Ø P to have a maximum draft angle of 1.5 to the top of the part with a maximum hole diameter of 3.91 mm (0.154").

7. Outline conforms to JEDEC outline TO-247 with exception of dimension c.

8. Xian and Mingxin actually photo.



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